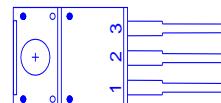
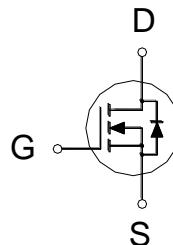


**NIKO-SEM****N-Channel Enhancement Mode  
Field Effect Transistor****P1050ETF  
TO-220F  
Halogen-Free & Lead-Free****PRODUCT SUMMARY**

| $V_{(BR)DSS}$ | $R_{DS(ON)}$  | $I_D$ |
|---------------|---------------|-------|
| 500V          | 705m $\Omega$ | 10A   |



1. GATE
2. DRAIN
3. SOURCE

**100% UIS tested****ABSOLUTE MAXIMUM RATINGS ( $T_A = 25^\circ\text{C}$  Unless Otherwise Noted)**

| PARAMETERS/TEST CONDITIONS                     | SYMBOL         | LIMITS     | UNITS |
|--|----------------|------------|-------|
| Drain-Source Voltage                           | $V_{DS}$       | 500        | V     |
| Gate-Source Voltage                            | $V_{GS}$       | $\pm 30$   | V     |
| Continuous Drain Current <sup>2,4</sup>        | $I_D$          | 10         | A     |
|  |                | 6.3        |       |
| Pulsed Drain Current <sup>1,2</sup>            | $I_{DM}$       | 30         |       |
| Avalanche Current <sup>3</sup>                 | $I_{AS}$       | 5.9        | A     |
| Avalanche Energy <sup>3</sup>                  | $E_{AS}$       | 174        | mJ    |
| Power Dissipation                              | $P_D$          | 48         | W     |
|  |                | 19         |       |
| Operating Junction & Storage Temperature Range | $T_j, T_{stg}$ | -55 to 150 | °C    |

**THERMAL RESISTANCE RATINGS**

| THERMAL RESISTANCE  | SYMBOL          | TYPICAL | MAXIMUM | UNITS  |
|---------------------|-----------------|---------|---------|--------|
| Junction-to-Case    | $R_{\theta JC}$ |         | 2.6     | °C / W |
| Junction-to-Ambient | $R_{\theta JA}$ |         | 62.5    | °C / W |

<sup>1</sup>Pulse width limited by maximum junction temperature.<sup>2</sup>Limited only by maximum temperature allowed.<sup>3</sup> $V_{DD} = 50\text{V}$ ,  $L = 10\text{mH}$ , starting  $T_J = 25^\circ\text{C}$ .<sup>4</sup>This characteristics assumes the die are assembled in TO-220 packages.**ELECTRICAL CHARACTERISTICS ( $T_J = 25^\circ\text{C}$ , Unless Otherwise Noted)**

| PARAMETER                      | SYMBOL        | TEST CONDITIONS                                  | LIMITS |     |           | UNIT |
|--------------------------------|---------------|--|--------|-----|-----------|------|
|                                |               |  | MIN    | TYP | MAX       |      |
| <b>STATIC</b>                  |               |  |        |     |           |      |
| Drain-Source Breakdown Voltage | $V_{(BR)DSS}$ | $V_{GS} = 0\text{V}$ , $I_D = 250\mu\text{A}$    | 500    |     |           | V    |
| Gate Threshold Voltage         | $V_{GS(th)}$  | $V_{DS} = V_{GS}$ , $I_D = 250\mu\text{A}$       | 2      | 3   | 4         |      |
| Gate-Body Leakage              | $I_{GSS}$     | $V_{DS} = 0\text{V}$ , $V_{GS} = \pm 30\text{V}$ |        |     | $\pm 100$ | nA   |

**NIKO-SEM****N-Channel Enhancement Mode  
Field Effect Transistor**

**P1050ETF**  
**TO-220F**  
**Halogen-Free & Lead-Free**

|   |              |   |  |      |     |           |
|---|--------------|---|--|------|-----|-----------|
| Gate Voltage Drain Current  | $I_{DSS}$    | $V_{DS} = 500V, V_{GS} = 0V, T_C = 25^\circ C$  |  |      | 1   | $\mu A$   |
|   |              | $V_{DS} = 400V, V_{GS} = 0V, T_C = 100^\circ C$ |  |      | 100 |           |
| Drain-Source On-State Resistance <sup>1</sup>   | $R_{DS(ON)}$ | $V_{GS} = 10V, I_D = 5A$                        |  | 513  | 705 | $m\Omega$ |
| Forward Transconductance <sup>1</sup>   | $g_{fs}$     | $V_{DS} = 10V, I_D = 5A$                        |  | 13   |     | S         |
| <b>DYNAMIC</b>  |              |   |  |      |     |           |
| Input Capacitance   | $C_{iss}$    | $V_{GS} = 0V, V_{DS} = 25V, f = 1MHz$           |  | 1110 |     | $pF$      |
| Output Capacitance  | $C_{oss}$    |   |  | 130  |     |           |
| Reverse Transfer Capacitance  | $C_{rss}$    |   |  | 15.6 |     |           |
| Gate Resistance   | $R_g$        | $V_{GS} = 0V, V_{DS} = 0V, f = 1MHz$            |  | 2.3  |     | $\Omega$  |
| Total Gate Charge <sup>2</sup>  | $Q_g$        | $V_{DD} = 400V, I_D = 10A, V_{GS} = 10V$        |  | 31   |     | $nC$      |
| Gate-Source Charge <sup>2</sup>   | $Q_{gs}$     |   |  | 5    |     |           |
| Gate-Drain Charge <sup>2</sup>  | $Q_{gd}$     |   |  | 11   |     |           |
| Turn-On Delay Time <sup>2</sup>   | $t_{d(on)}$  | $V_{DD} = 250V, I_D = 10A, R_G = 25\Omega$      |  | 24   |     | $nS$      |
| Rise Time <sup>2</sup>  | $t_r$        |   |  | 44   |     |           |
| Turn-Off Delay Time <sup>2</sup>  | $t_{d(off)}$ |   |  | 123  |     |           |
| Fall Time <sup>2</sup>  | $t_f$        |   |  | 61   |     |           |
| <b>SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS (<math>T_J = 25^\circ C</math>)</b> |              |   |  |      |     |           |
| Continuous Current <sup>3</sup>   | $I_S$        |   |  |      | 10  | A         |
| Forward Voltage <sup>1</sup>  | $V_{SD}$     | $I_F = 10A, V_{GS} = 0V$                        |  |      | 1   | V         |
| Reverse Recovery Time   | $t_{rr}$     | $I_F = 10A, dI_F/dt = 100A / \mu S$             |  | 382  |     | $nS$      |
| Reverse Recovery Charge   | $Q_{rr}$     |   |  | 3.3  |     | $uC$      |

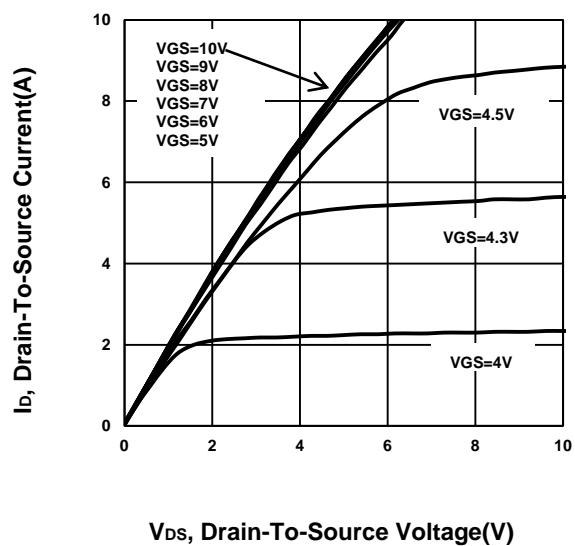
<sup>1</sup>Pulse test : Pulse Width  $\leq 380 \mu sec$ , Duty Cycle  $\leq 2\%$ .<sup>2</sup>Independent of operating temperature.<sup>3</sup>Pulse width limited by maximum junction temperature.

**NIKO-SEM**

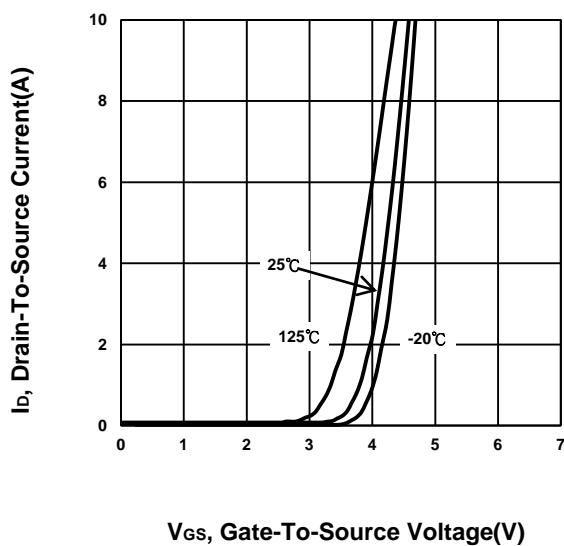
**N-Channel Enhancement Mode  
Field Effect Transistor**

**P1050ETF  
TO-220F  
Halogen-Free & Lead-Free**

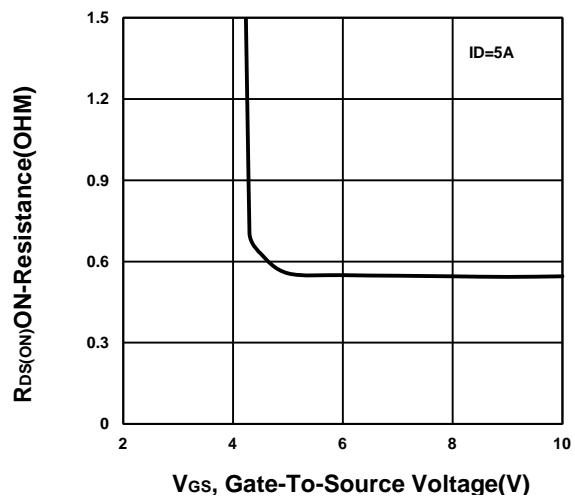
### Output Characteristics



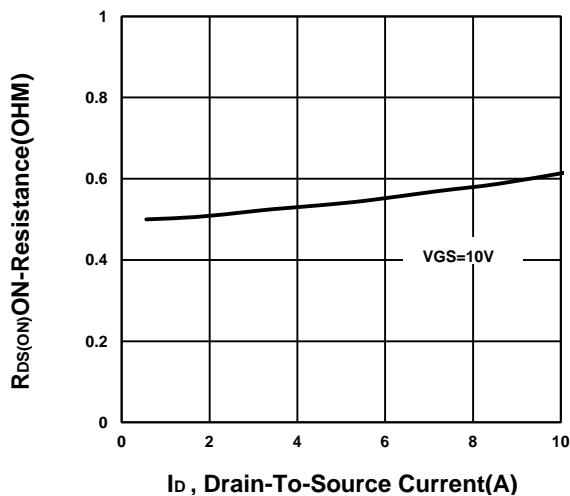
### Transfer Characteristics



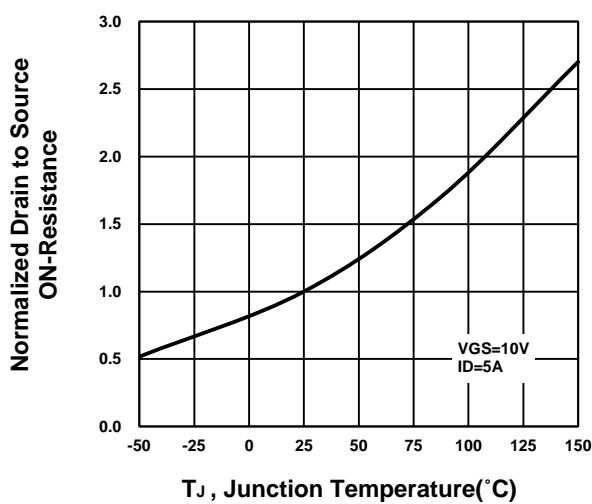
### On-Resistance VS Gate-To-Source Voltage



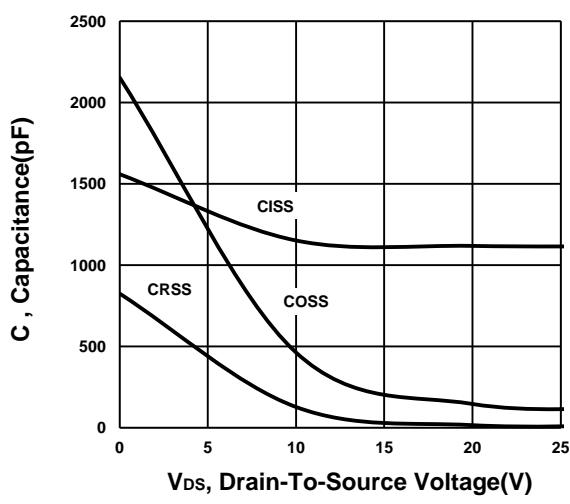
### On-Resistance VS Drain Current

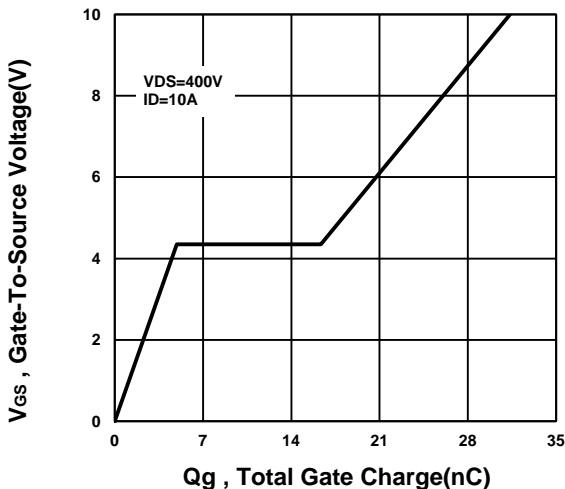
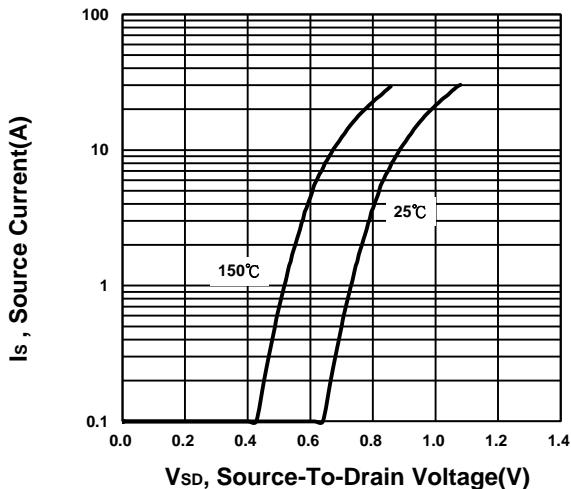
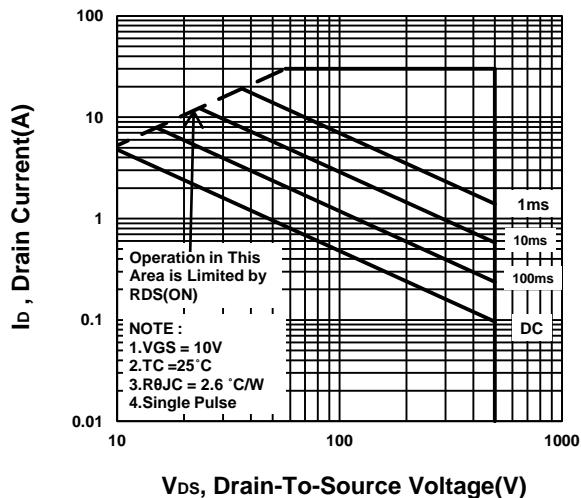
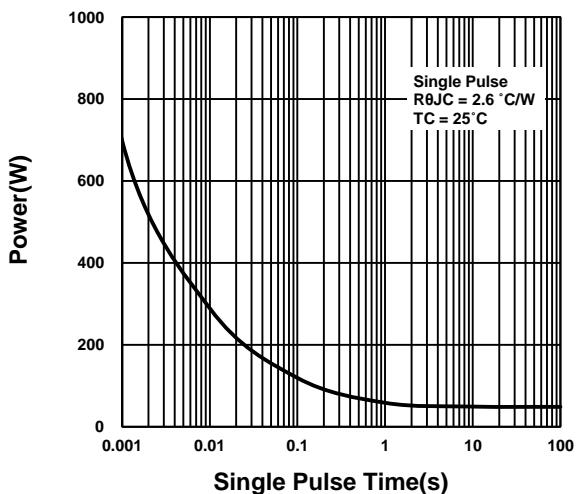


### On-Resistance VS Temperature



### Capacitance Characteristic



**NIKO-SEM****N-Channel Enhancement Mode  
Field Effect Transistor****P1050ETF  
TO-220F  
Halogen-Free & Lead-Free****Gate charge Characteristics****Source-Drain Diode Forward Voltage****Safe Operating Area****Single Pulse Maximum Power Dissipation****Transient Thermal Response Curve**